

Search Notes


Application/Control No.

10/075,035

Examiner

Hien Tran Neckel

 Applicant(s)/Patent under
Reexamination

LIU ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
422	177,180, 171	6/2/2005	HT
55	385.3, 483	6/2/2005	HT
55	484, 499,	6/2/2005	HT
55	523-525,	6/2/2005	HT
55	521	6/2/2005	HT
55	dig.10,	6/2/2005	HT
55	dig.28,	6/2/2005	HT
55	dig.30	6/2/2005	HT
60	311	6/2/2005	HT
updated	search	10/24/2005	HT
updated	search	3/10/2006	HT
updated	search	9/21/06	SSW
Updated Search		11/21/06	TD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPGPub	Text Search	11/21/06	TD
	Searched above		
	Class/subclass		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Image class/subclass search / Inventor's name search /text search/checked related applications 09/522,152 and 09/851,300	6/2/2005	HT
Updated search	9/21/06	SSW
Updated Search	11/21/06	TD